


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590339	<b>Applicant(s)/Patent Under Reexamination</b>  SHIN ET AL.
	<b>Examiner</b>  David Phantana-angkool	<b>Art Unit</b>  2175

SEARCHED			
Class	Subclass	Date	Examiner
715	400, 825	6/5/2009	DP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST -(see attached)	11/19/2008	DP
UPDATE SEARCH	6/5/2009	DP
UPDATE SEARCH	12/18/2009	DP
UPDATE SEARCH	8/13/2011	DP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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